Search Notes

Appli	cation,	Control	No.

Applicant(s)/Patent under Reexamination

10/624,456

KERTH ET AL.

Examiner

Art Unit

LEE NGUYEN

SEARCHED					
Class	Subclass	Date	Examiner		
455	296 300 301	4/26/2006	LN		
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330	170	4/26/2006	LN		
UDATE	SEARCH	10/17/2007	LN		
	ALL ABOVE				
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPG-PUB; USPAT; EPO; JPO; DERWENT) SEE SEARCH HISTORY	4/26/2006	LN		